

The manufacturer  
may use the mark:



**Reports:**

DET 11/06-065 R004 V1R2  
IEC 61508 Assessment  
X2200\_5200\_9800

DET 11/06-064 R003 V1 R3  
NUVIR FMEDA Report

**Validity:**

This assessment is valid for  
the X2200/5200/9800 Flame  
Detector.

This assessment is valid until  
January 1, 2015.

Revision 1.0 December 21, 2011



# Certificate / Certificat Zertifikat / 合格証

DET 1106065 C001

*exida* hereby confirms that the:

**X2200/5200/9800  
Flame Detectors**

**Detector Electronics Corporation  
Minneapolis, MN - USA**

Has been assessed per the relevant requirements of:

**IEC 61508 : 2010 Parts 1-7**

and meets requirements providing a level of integrity to:

**Systematic Integrity: SIL 2 Capable**

**Random Integrity: Type B Element**

**PFD<sub>AVG</sub> and Architecture Constraints  
must be verified for each application**

Safety Function:

The Flame Detectors will sense the presence of flame via UV  
and/or IR, and output the intensity within the Safety Accuracy on  
the 4 – 20 mA or relay output.

Application Restrictions:

The unit must be properly designed into a Safety Instrumented  
Function per the Safety Manual requirements.



*John C. Yazallinas*  
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Evaluating Assessor

*Ranjit B. Bhat*  
\_\_\_\_\_  
Certifying Assessor

# Certificate / Certificat / Zertifikat / 合格証

DET 1106065 C001

**Systematic Integrity: SIL 2 Capable**

**Random Integrity: Type B Element**

**PFD<sub>AVG</sub> and Architecture Constraints  
must be verified for each application**

**X2200/5200/9800  
Flame Detectors**

**Detector Electronics  
Corporation**

**Minneapolis, MN - USA**

SIL 2 Capability:

The product has met manufacturer design process requirements of Safety Integrity Level (SIL) 2. These are intended to achieve sufficient integrity against systematic errors of design by the manufacturer.

A Safety Instrumented Function (SIF) designed with this product must not be used at a SIL level higher than stated without "prior use" justification by end user or diverse technology redundancy in the design.

## IEC 61508 Failure Rates in FIT\*

Device	$\lambda_{SD}$	$\lambda_{SU}$	$\lambda_{DD}$	$\lambda_{DU}$	SFF
X2200 UV Relay	208	78	501	72	91.6%
X2200 UV Current	0	75	704	61	92.7%
X2200 UV mA w/HART	0	67	877	73	92.8%
X5200 UV/IR Relay	248	102	591	85	91.7%
X5200 UV/IR Current	0	98	834	74	92.6%
X5200 UV/IR mA w/HART	0	90	1007	86	92.7%
X9800 IR Relay	220	95	412	79	90.2%
X9800 IR Current	0	93	628	68	91.4%
X9800 IR mA w/HART	0	84	800	80	91.7%

SIL Verification:

The Safety Integrity Level (SIL) of an entire Safety Instrumented Function (SIF) must be verified via a calculation of PFD<sub>AVG</sub> considering redundant architectures, proof test interval, proof test effectiveness, any automatic diagnostics, average repair time and the specific failure rates of all products included in the SIF. Each subsystem must be checked to assure compliance with minimum hardware fault tolerance (HFT) requirements.

\* FIT = 1 failure / 10<sup>9</sup> hours



Form	Version	Date
C61508	2.7-2	Mar 2011